Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/568,678	NAKAJIMA ET AL.	
Examiner	Art Unit	
NGUYEN T. HA	2831	

	SEAR	CHED	
Class	Subclass	Date	Examiner
361	328-330	3/15/2008	NH
	306.1		
	306.3		
	311-313		
	302-305		

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner

SEAR (INCLUDING SI	CH NOTES EARCH STRAT	EGY)
	DAT	
EAST SEARCH	3/15/2	008 NH